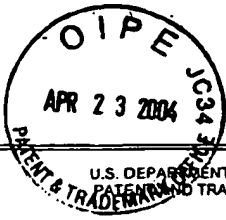


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201326US2		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Minoru TAKAYA, et al.			
				FILING DATE HEREWITH		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
I	AO	8-69712	03/12/96	Japan (with English Abstract)		X	
	AP	10-270255	10/09/98	Japan (with English Abstract)		X	
	AQ	11-192620	07/21/99	Japan (with English Abstract)		X	
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner					Date Considered 03/06		
<small>Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

201326US2

SERIAL NO.

09/749,800

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Minoru TAKAYA, et al.

FILING DATE

December 28, 2000

GROUP

1773

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
2	AA	3,993,626	11/23/76	J. J. LAURITO			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
2	AO	25 01 843	06/16/76	GERMANY (with corr. US 3,993,626)		X
2	AP	1 246 829	09/22/71	GREAT BRITAIN		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered 03/06

Examiner: Initial if reference is considered; whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

201326US2

SERIAL NO.

09/749,800


 LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Minoru TAKAYA, et al.


FILING DATE

December 28, 2000

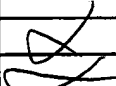
GROUP

1773

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	3,993,626	11/23/76	J. J. LAURITO			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	25 01 843	06/16/76	GERMANY (with corr. US 3,993,626)		X
	AP	1 246 829	09/22/71	GREAT BRITAIN		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

03/06

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

COPY

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201326US2		SERIAL NO. 09/749,800	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Minoru TAKAYA, et al.			
				FILING DATE December 28, 2000		GROUP 1773	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,470,400	11/28/95	Y. BOGATIN, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
	AO	6-204021	07/22/94	JAPAN (with English Abstract)		X	
	AP	8-78798	03/22/96	JAPAN (with English Abstract)		X	
	AQ	0 383 035	08/22/90	EUROPE			
	AR	0 878 984	11/18/98	EUROPE			
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	G. VIAU, et al., Journal of Applied Physics, vol. 76, no. 10, Part 2, XP-000508787, pages 6570-6572, "PREPARATION AND MICROWAVE CHARACTERIZATION OF SPHERICAL AND MONODISPERSE Co <sub>20</sub> Ni <sub>80</sub> PARTICLES", November 15, 1994					
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner				03/06		Date Considered 03/06	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

COPY